


<b>Search Notes</b>  	<b>Application/Control No.</b>  10588369	<b>Applicant(s)/Patent Under Reexamination</b>  BANIN ET AL.
	<b>Examiner</b>  John P Dulka	<b>Art Unit</b>  2895

SEARCHED			
Class	Subclass	Date	Examiner
257	288	2/26/2009	JPD
257	497	2/26/2009	JPD
257	009	2/26/2009	JPD

SEARCH NOTES		
Search Notes	Date	Examiner
East author search (US Patent / US PGPUB / DERWENT / IBM_TDB / EPO / JPO / FPRS)	2/26/2009	JPD
East number search (US Patent / US PGPUB / Derwent / IBM_TDB / EPO / JPO / FPRS)	10/21/2009	JPD
East tagged search (US Patent / US PGPUB / Derwent / IBM_TDB / EPO / JPO / FPRS)	6/17/2011	JPD
East forward/back search (US Patent / US PGPUB / Derwent / IBM_TDB / EPO / JPO / FPRS)	6/17/2011	JPD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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